N-Channel Power MOSFET 600 V, 1.2 Ω

Features

- Low ON Resistance
- Low Gate Charge
- ESD Diode–Protected Gate

Rating

• 100% Avalanche Tested

Drain-to-Source Voltage

• These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Symbol

V_{DSS}

ABSOLUTE MAXIMUM RATINGS (T_C = 25°C unless otherwise noted)



ON Semiconductor®

www.onsemi.com

V _{DSS} (@ T _{Jmax})	R _{DS(ON)} (MAX) @ 3 A
650 V	1.2 Ω





$eq:linear_line$				
$\begin{array}{ c c c c c } \hline T_A = 100^\circ C, \ R_{\theta JC} \ (Note 1) & I_{DM} & I_{DM} & 28 \\ \hline Pulsed Drain Current, \\ V_{GS} @ 10 V & P_D & 35 \\ \hline Power Dissipation, \ R_{\theta JC} & P_D & 35 \\ \hline Gate-to-Source Voltage & V_{GS} & \pm 30 \\ \hline Single Pulse Avalanche Energy, \ L = 6.3 \ mH, \\ \ I_D = 6.0 \ A & I13 \\ \hline ESD \ (HBM) \ (JESD22-A114) & V_{esd} & 3000 \\ \hline RMS \ Isolation \ Voltage \\ (t = 0.3 \ sec., \ R.H. \le 30\%, \\ \ T_A = 25^\circ C) \ (Figure 13) & V_{ISO} & V_{ISO} \\ \hline Peak \ Diode \ Recovery \ (Note 2) & dv/dt & 4.5 \\ \hline MOSFET \ dV/dt & d0 \\ \hline MOSFET \ dV/dt & d0 \\ \hline Maximum \ Temperature \ for \ Soldering \ Leads & T_L & 260 \\ \hline Operating \ Junction \ and & T_J, \ T_{stg} & -55 \ to \\ \hline \end{array}$	Continuous Drain Current, $R_{\theta JC}$ (Note 1)	Ι _D	7.1	Α
$\begin{array}{c c c c c c c c c c c c c c c c c c c $		Ι _D	4.5	A
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $		I _{DM}	28	A
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	Power Dissipation, $R_{\theta JC}$	PD	35	W
$\begin{split} & I_{D} = 6.0 \ A & N_{S} & N_{S} & N_{S} & M_{S} \\ & ESD \ (HBM) \ (JESD22-A114) & V_{esd} & 3000 & M_{S} \\ & RMS \ Isolation \ Voltage & V_{ISO} & 4500 & V_{ISO} \\ & (t = 0.3 \ sec., \ R.H. \le 30\%, & V_{ISO} & 4500 & M_{S} \\ & T_{A} = 25^\circC) \ (Figure \ 13) & V_{ISO} & dv/dt & 4.5 & M_{S} \\ & Peak \ Diode \ Recovery \ (Note \ 2) & dv/dt & 4.5 & M_{S} \\ & MOSFET \ dV/dt & dV & d0 & M_{S} \\ & MOSFET \ dV/dt & d00 & M_{S} \\ & Continuous \ Source \ Current \ (Body \ Diode) & I_{S} & 6.0 & M_{S} \\ & Maximum \ Temperature \ for \ Soldering \ Leads & T_{L} & 260 & M_{S} \\ & Operating \ Junction \ and & T_{J, \ Tstg} & -55 \ to & Soldering \ Leads & T_{L} & Soldering \ Leads \\ \end{array} $	Gate-to-Source Voltage	V _{GS}	±30	V
$ \begin{array}{c c} RMS \mbox{ Isolation Voltage} \\ (t = 0.3 \mbox{ sec.}, \mbox{ R.H.} \le 30\%, \\ T_A = 25^\circ \mbox{C} \mbox{ (Figure 13)} \end{array} & \begin{array}{c} V_{\rm ISO} \\ dv/dt \\ dv/dt \\ dt $	с с,	E _{AS}	113	mJ
$ \begin{array}{c c} (t=0.3 \mbox{ sec.}, R.H. \leq 30\%, \\ T_A=25^{\circ}C) \mbox{ (Figure 13)} \end{array} & \label{eq:rescaled} \end{tabular} \\ \hline Peak Diode Recovery (Note 2) & dv/dt & 4.5 & V \\ \hline MOSFET dV/dt & dV/dt & 60 & V \\ \hline Continuous Source Current (Body Diode) & I_S & 6.0 & V \\ \hline Maximum Temperature for Soldering Leads & T_L & 260 & V \\ \hline Operating Junction and & T_J, T_{stg} & -55 \ to & V \\ \hline \end{array} $	ESD (HBM) (JESD22–A114)	V _{esd}	3000	V
MOSFET dV/dt dV/dt 60 N Continuous Source Current (Body Diode) I _S 6.0 N Maximum Temperature for Soldering Leads T _L 260 1 Operating Junction and T _J , T _{stg} -55 to 1	(t = 0.3 sec., R.H. ≤ 30%,	V _{ISO}	4500	V
Continuous Source Current (Body Diode) IS 6.0 Maximum Temperature for Soldering Leads TL 260 Operating Junction and TJ, Tstg -55 to	Peak Diode Recovery (Note 2)	dv/dt	4.5	V/ns
Maximum Temperature for Soldering Leads TL 260 Operating Junction and TJ, Tstg -55 to	MOSFET dV/dt	dV/dt	60	V/ns
Operating Junction and TJ, Tstg -55 to	Continuous Source Current (Body Diode)	۱ _S	6.0	А
, o, o,g	Maximum Temperature for Soldering Leads	TL	260	°C
Storage Temperature Range 150	Operating Junction and Storage Temperature Range	T _J , T _{stg}	–55 to 150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Limited by maximum junction temperature

2. $I_{SD} = 6.0$ Å, di/dt ≤ 100 Å/ μ s, $V_{DD} \leq BV_{DSS}$, $T_J = +150^{\circ}C$

ORDERING AND MARKING INFORMATION

See detailed ordering, marking and shipping information on page 6 of this data sheet.

Unit

v

Value

600

THERMAL RESISTANCE

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ ext{ heta}JC}$	3.6	°C/W
Junction-to-Ambient Steady State (Note 3)	R_{\thetaJA}	50	

3. Insertion mounted

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise noted)

Characteristic	Test Conditions		Symbol	Min	Тур	Max	Unit	
OFF CHARACTERISTICS								
Drain-to-Source Breakdown Voltage	V_{GS} = 0 V, I_D = 1 mA		BV _{DSS}	600			V	
Breakdown Voltage Temperature Co- efficient	Reference to 25°C, $I_D = 1 \text{ mA}$		$\Delta BV_{DSS}/\Delta T_{J}$		0.6		V/°C	
Drain-to-Source Leakage Current		25°C	I _{DSS}			1	μA	
	$V_{DS} = 600 \text{ V}, V_{GS} = 0 \text{ V}$	150°C				50		
Gate-to-Source Forward Leakage	$V_{GS} = \pm 20 \text{ V}$	•	I _{GSS}			±10	μA	
ON CHARACTERISTICS (Note 4)								
Static Drain-to-Source On-Resistance	V_{GS} = 10 V, I _D = 3.0 A		R _{DS(on)}		0.98	1.2	Ω	
Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 100 \ \mu A$	۱.	V _{GS(th)}	3.0	3.9	4.5	V	
Forward Transconductance	V _{DS} = 15 V, I _D = 3.0 A		9 _{FS}		5.0		S	
OYNAMIC CHARACTERISTICS								
Input Capacitance (Note 5)			C _{iss}	738	923	1107	pF	
Output Capacitance (Note 5)	$V_{DS} = 25 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$		C _{oss}	90	106	125		
Reverse Transfer Capacitance (Note 5)	f = 1.0 MHz		C _{rss}	15	23	30		
Total Gate Charge (Note 5)			Qg	15.5	31	47	nC	
Gate-to-Source Charge (Note 5)			Q _{gs}	3	6.3	9.5		
Gate-to-Drain ("Miller") Charge (Note 5)	Vpp = 300 V. lp = 6.0 A.		Q _{gd}	8	17	24.5	1	
Plateau Voltage			V _{GP}		6.4		V	
Gate Resistance			Rg		3.2		Ω	
RESISTIVE SWITCHING CHARACTERI	STICS		•		•			
Turn-On Delay Time			t _{d(on)}		13		ns	
Rise Time	V _{DD} = 300 V, I _D = 6.0 A,		t _r		17		1	
Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, \text{ R}_{G} = 5 \Omega$		t _{d(off)}		30	1	1	
Fall Time			t _f		28	1		
SOURCE-DRAIN DIODE CHARACTER	STICS (T _C = 25°C unless other	vise noted))		-	-	-	
Diode Forward Voltage	I _S = 6.0 A, V _{GS} = 0 V	,	V _{SD}			1.6	V	
Reverse Recovery Time	V _{GS} = 0 V, V _{DD} = 30 V		t _{rr}		338		ns	
Reverse Recovery Charge	I _S = 6.0 A, di/dt = 100 A/µ	ιS	Q _{rr}		2.0	1	μC	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Pulse Width \leq 380 µs, Duty Cycle \leq 2%.

5. Guaranteed by design.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



Figure 12. Thermal Impedance for NDF06N60Z





Measurement made between leads and heatsink with all leads shorted together.

*For additional mounting information, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ORDERING INFORMATION

Order Number	Package	Shipping [†]
NDF06N60ZG	TO–220FP (Pb–Free, Halogen–Free)	50 Units / Rail
NDF06N60ZH	TO-220FP (Pb-Free, Halogen-Free)	50 Units / Rail

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

MARKING DIAGRAMS



= Location Code А Υ

- WW = Work Week
- G, H = Pb-Free, Halogen-Free Package

PACKAGE DIMENSIONS

TO-220 FULLPACK, 3-LEAD CASE 221AH

ISSUE F



NOTES: DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.

- CONTROLLING DIMENSION: MILLIMETERS.
 CONTOUR UNCONTROLLED IN THIS AREA.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH AND GATE PROTRUSIONS. MOLD FLASH AND GATE PROTRUSIONS NOT TO 4. EXCEED 0.13 PER SIDE. THESE DIMENSIONS ARE TO BE MEASURED AT OUTERMOST EXTREME OF THE PLASTIC BODY. DIMENSION b2 DOES NOT INCLUDE DAMBAR PROTRUSION. LEAD WIDTH INCLUDING PROTRUSION SHALL NOT EXCEED 2.00.

- CONTOURS AND FEATURES OF THE MOLDED PACKAGE BODY 6. MAY VARY WITHIN THE ENVELOP DEFINED BY DIMENSIONS A1 AND H1 FOR MANUFACTURING PURPOSES.

	MILLIMETERS		
DIM	MIN	MAX	
Α	4.30	4.70	
A1	2.50	2.90	
A2	2.50	2.90	
b	0.54	0.84	
b2	1.10	1.40	
C	0.49	0.79	
D	14.70	15.30	
Е	9.70	10.30	
е	2.54 BSC		
H1	6.60	7.10	
L	12.50	14.73	
L1		2.80	
Ρ	3.00	3.40	
Q	2.80	3.20	

SECTION D-D



ALTERNATE CONSTRUCTION

NOTE 6 **SECTION A-A**

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